

**Notice of References Cited**

Application/Control No.

10/563,920

Applicant(s)/Patent Under

Reexamination

HAYNES ET AL.

Examiner

YOSHITOSHI TAKEUCHI

Art Unit

4162

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*	C US-6,521,783	02-2003	Wegman et al.	560/232
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
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